

Notice of References Cited	Application/Control No. 10/780,453	Applicant(s)/Patent Under Reexamination NAKANISHI ET AL.	
	Examiner Kenneth J. Whittington	Art Unit 2862	Page 1 of 1

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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